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Application/Control No.	Applicant(s)/Patent under Reexamination	•
09/488,969	BAER ET AL.	
Examiner	Art Unit	
Maikhanh Nguyen	2176	

SEARCHED			
Class	Subclass	Date	Examiner
Updated	Search	9/9/2005	MK
Updated	Search	2/24/2006	MK
Updated	Search	8/8/2006	MK
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARCH		
	DATE	EXMR
Inventor Name Search	9/9/2005	MK
West Updated Search (See Search History Printout)	9/9/2005	MK
West Updated (See Search History Printout)	2/24/2006	MK
West Updated (See Search History Printout)	8/8/2006	MK